


<div>Search Notes</div> <div></div>	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/709,735	WEN ET AL.	
	Examiner	Art Unit	
	Patrick M. Moore	2188	

SEARCHED			
Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
PLUS Search from EIC (50 Max)	9/14/2006	PMM
Inventor Name Search using PALM General Information	9/17/2006	PMM
711/112,4,115; 717/168,174; 713/2; Classification Search and narrowed with Text Search	9/17/2006	PMM